## SIEMENS

## Data sheet

## 6AU1445-2AD00-0AA1



SIMOTION drive-based Control Unit D445-2 DP/PN; programmable motion control system; high performance; interfaces: 12 DI 16 DI/DQ, 6 DRIVE-CLiQ 2 PROFIBUS, 3 PROFINET ports 2 Ethernet, 2 USB 1 option slot; incl. dual fan/ battery module and battery

0.4	
product brand name	SIMOTION
product type designation	D445-2 DP/PN
Performance class for motion control system	HIGH Performance
Version of the motion control system	Multiple-axis system
PLC and motion control performance	
number of axes / maximum	64
Minimum PROFIBUS cycle clock	1 ms
Minimum PROFINET send cycle clock	0.25 ms
Minimum interpolator cycle clock	0.25 ms
Minimum servo cycle clock	0.25 ms
• note	0.25 ms for SERVO or SERVO-FAST
Integrated drive control / header	
Maximum number of axes for integrated drive control	
• servo	6
• vector	6
• V/f	12
• note	Alternative control modes; drive control based on SINAMICS S120 CU320-2, firmware version V4.x/V5.x
Memory	
RAM (work memory)	196 Mbyte
Additional RAM work memory for Java applications	20 Mbyte
RAM disk (load memory)	68 Mbyte
Retentive memory	512 kbyte
Persistent memory (user data on CF)	1.5 Gbyte
Communication	
Interfaces	
DRIVE-CLIQ	6
• USB	2
Industrial Ethernet	2
PROFIBUS	2
— note	Equidistant and isochronous; Can be configured as master or slave
PROFINET	1
— note	1 interface with 3 ports onboard; 1 interface with 4 ports optional via CBE30-2; functionality: supports PROFINET IO with IRT and RT; configurable as PROFINET IO Controller and/or Device; supports media redundancy (MRP and MRPD)
General technical data	
Fan	Double fan/battery module included in scope of delivery
DC supply voltage	
rated value	24 V
• minimum	20.4 V

• maximum	28.8 V
consumed current / typical	1 900 mA
• note	with no load on inputs/outputs, no 24 V supply via DRIVE-CLiQ and PROFIBUS interface
Making current, typ.	5 A
Power loss, typ.	46 W
Ambient temperature, during	
Iong-term storage	-25 +55 °C
• transport	-40 +70 °C
• operation	0 55 °C
— note	Maximum installation altitude 4000 m (13124 ft) above sea level. Above an
	altitude of 2000 m (6562 ft), the maximum ambient temperature decreases by 7 °C (12.6 °F) per 1000 m (3281 ft).
Relative humidity	
<ul> <li>during operation</li> </ul>	5 95 %
<ul> <li>without condensation, tested acc. to IEC 60068-2-38</li> </ul>	Wert fehlt
Product property / Conformal coating	No
Resistance	
<ul> <li>to biologically active substances, / conformity acc. to EN 60721-3-3</li> </ul>	No
<ul> <li>to chemically active substances, / conformity acc. to EN 60721-3-3</li> </ul>	No
Air pressure	620 1 060 hPa
Degree of protection	IP20 / UL open type
height	380 mm
width	50 mm
• depth	270 mm
Depth / Note	When the spacer is removed 230 mm (9.05 in) deep
net weight	4 300 g
Digital inputs / header	
number of digital incute	12
number of digital inputs	1 -
number of digital inputs DC input voltage	
DC input voltage • rated value	24 V
DC input voltage <ul> <li>rated value</li> </ul>	
DC input voltage • rated value • for signal "1"	24 V
DC input voltage • rated value • for signal "1" • for signal "0"	24 V 15 30 V
DC input voltage • rated value • for signal "1"	24 V 15 30 V -3 +5 V Yes
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ.	24 V 15 30 V -3 +5 V Yes
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA
DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" → "1", typ.	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA
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DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ.	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA
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DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ. Digital inputs/outputs / header Number of digital I/Os Parameterization possibility of the digital I/Os	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA 50 μs 150 μs 16 can be parameterized - as DI - as DO - as probe input (max. 16) - as cam
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DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ. Digital inputs/outputs / header Number of digital I/Os Parameterization possibility of the digital I/Os If used as an input / header DC input voltage	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA 50 μs 150 μs 16 can be parameterized - as DI - as DO - as probe input (max. 16) - as cam output (max. 8)
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DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation • note Current consumption for "1" signal level, typ. Input delay time for • signal "0" $\rightarrow$ "1", typ. • signal "0" $\rightarrow$ "1", typ. • signal "1" $\rightarrow$ "0", typ. Digital inputs/outputs / header Number of digital I/Os Parameterization possibility of the digital I/Os If used as an input / header DC input voltage • rated value • for signal "1" • for signal "0" Electrical isolation Current consumption for "1" signal level, typ. Input delay time for	24 V 15 30 V -3 +5 V Yes Yes, in groups of 6 9 mA 50 μs 150 μs 16 can be parameterized - as DI - as DO - as probe input (max. 16) - as cam output (max. 8) 24 V 15 30 V -3 +5 V No 9 mA
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• maximum	28.8 V
Electrical isolation	No
Current carrying capacity for each output, max.	500 mA
Leakage current, max.	2 mA
Output delay for	
• signal "0" $\rightarrow$ "1", typ.	150 µs
• signal "0" $\rightarrow$ "1", max.	400 µs
• signal "1" $\rightarrow$ "0", typ.	75 µs
• signal "1" $\rightarrow$ "0", max.	150 µs
— note	Data for Vcc = 24 V; load 48 Ohm; "1" = 90 % VOut, "0" = 10 % VOut
Cam output	
reproducibility	10 µs
resolution	1 µs
Switching frequency of the outputs for	
<ul> <li>resistive load, max.</li> </ul>	4 kHz
<ul> <li>inductive load, max.</li> </ul>	2 Hz
<ul> <li>lamp load, max.</li> </ul>	11 Hz
Short-circuit protection	Yes
Additional technical data	
Back-up of non-volatile data	
<ul> <li>of retentive data</li> </ul>	unlimited buffer duration
<ul> <li>of real-time clock, min.</li> </ul>	4 d
• note	longer buffer duration of the real-time clock using a battery inserted in the double fan/battery module
Approvals	
• USA	cULus
• Canada	cULus
• Australia	RCM (formerly C-Tick)
• Korea	KCC
<ul> <li>Russia, Belarus and Kazakhstan</li> </ul>	EAC

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